

ATTY DOCKET NO.
03500.005745.36APPLICATION NO.
09/384,326

APPLICANT

SEISHIRO YOSHIOKA ET AL.

FILING DATE

MAY 12, 2000

GROUP

2879

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
MAT	5,185,554	2/93	Nomura et al.	313	495	
MAT	4,954,744	9/90	Suzuki et al.	313	336	
MAT	5,285,129	2/94	Takeda et al.	13	309	
MAT	5,256,936	10/93	Itoh et al.	313	309	
MAT	5,559,342	9/96	Tsukamoto et al.	257	10	
MAT	5,141,460	8/92	Jaskie et al.	313	309	
MAT	3,611,077	10/71	Smith	315	94	
MAT	3,631,291	12/71	Favreau	313	346	
MAT	3,983,443	9/76	Schade	313	346DC	
MAT	4,093,562	6/78	Kishimoto	313	103CM	
MAT	4,672,268	6/87	Duenisch et al.	313	346R	
MAT	4,663,559	5/87	Christensen	313	346R	
MAT	4,721,524	1/88	Sheldon et al.	75	0.5A	9/19/86
MAT	2,887,413	5/59	Ekkers et al.	313	341	
MAT	4,680,500	7/87	Buck	313	346R	3/6/86
MAT	3,766,423	10/73	Menelly	313	341	
MAT	3,581,151	5/71	Boyle et al.	257	10	
MAT	3,806,372	4/74	Sommer	257	10	
MAT	3,814,968	6/74	Nathanson et al.	257	10	
MAT	4,303,930	12/81	Van Gorkom et al.	257	10	
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LIST OF REFERENCES CITED BY APPLICANT(S)
(Use several sheets if necessary)

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*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
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MW	5,063,327	11/91	Brodie et al.	313	495	—
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MW	3,663,857	5/72	Soellner	313	339	—

FOREIGN PATENT DOCUMENTS

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MW	64-31332A	2/89	JAPAN	H01J	029/48	ABSTRACT
MW	1-283749	11/89	JAPAN	H01J	031/15	ABSTRACT
MW	1-309242	12/89	JAPAN	H01J	37/66	ABSTRACT
MW	0536731A1	4/93	EPO	H01J	1/30	ENGLISH
MW	0523702A1	1/93	EPO	H01J	31/12	ENGLISH
MW	59-169034	9/84	JAPAN	H01J	1/14	ABSTRACT
MW	2060991A	5/81	UK	313	346R	ENGLISH
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MW	~	"Scanning Tunnelling Microscopic Investigations of Electroformed Planar Metal-insulator-metal Diodes", H. Pagnia, N. Sotnik and W. Wirth, Int. J. Electronics, Vol. 69 No. 1, 25-32 (1990) (no month)

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